



# **MOSFET** - Power, Single P-Channel, μ8FL

-30 V, 7.5 mΩ, -88.6 A

# NVTFS015P03P8Z

#### **Features**

- Ultra Low R<sub>DS(on)</sub> to Improve System Efficiency
- Advanced Package Technology in 3.3 x 3.3 mm for Space Saving and Excellent Thermal Conduction
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

# **Typical Applications**

- Power Load Switch
- Protection: Reverse Current, Over Voltage, and Reverse Negative Voltage
- Battery Management

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	-30	V
Gate-to-Source Voltage			$V_{GS}$	± 25	V
Continuous Drain Cur-	Steady	T <sub>C</sub> = 25°C	I <sub>D</sub>	-88.6	Α
rent R <sub>θJC</sub> (Notes 1, 2)	State	T <sub>C</sub> = 100°C		-62.6	
Power Dissipation R <sub>θJC</sub>		T <sub>C</sub> = 25°C	$P_{D}$	88.2	W
(Notes 1, 2)		T <sub>C</sub> = 100°C		44.1	
Continuous Drain Cur-	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-17	Α
rent R <sub>θJA</sub> (Notes 1, 2)	State	T <sub>A</sub> = 100°C		-12	
Power Dissipation R <sub>θJA</sub>		T <sub>A</sub> = 25°C	$P_{D}$	3.2	W
(Notes 1, 2)		T <sub>A</sub> = 100°C		1.6	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I <sub>DM</sub>	-353	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	–55 to 175	ç
Source Current (Body Diode)			IS	73.5	Α
Single Pulse Drain to Source Avalanche Energy ( $I_L = 8.5 \text{ A}$ )			E <sub>AS</sub>	88	mJ
Lead Temperature for So (1/8" from case for 10 s)	dering Pu	irposes	TL	260	°C

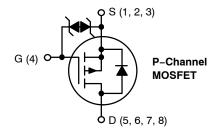
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain) (Note 2)	$R_{\theta JC}$	1.7	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	46.4	°C/W

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 1 in2, 2 oz. Cu pad. Assuming a 76 mm x 76 mm x 1.6 mm board.

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
-30 V	7.5 m $\Omega$ @ –10 V	-88.6 A
	12 mΩ @ –4.5 V	





#### WDFN8 (μ8FL) CASE 511AB



WDFNW8 (µ8FL WF) CASE 515AN

**MARKING DIAGRAMS** 





XXXXX = Specific Device Code = Assembly Location

= Year = Work Week WW = Pb-Free Package

(Note: Microdot may be in either location)

#### ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Con	dition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	<u> </u>			-	-	•	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>	$I_D$ = -250 $\mu$ A, ref to 25°C			-4.4		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -30 V	T <sub>J</sub> = 25°C			-10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{G}$	<sub>S</sub> = ±25 V			±10	μΑ
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= -250 μA	-1.0		-3.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	$I_D = -250 \mu A$ ,	ref to 25°C		5.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = -10 \text{ V},$	<sub>D</sub> = -12 A		5.0	7.5	mΩ
		$V_{GS} = -4.5 \text{ V},$	I <sub>D</sub> = -10 A		8.0	12	1
Froward Transconductance	9 <sub>FS</sub>	$V_{DS} = -5 \text{ V, I}$	<sub>O</sub> = -10 A		77		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -15 \text{ V}$			2706		pF
Output Capacitance	C <sub>oss</sub>				907		1
Reverse Transfer Capacitance	C <sub>rss</sub>				875		1
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V},$ $I_{D} = -10 \text{ A}$			37		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				5.1		
Gate-to-Source Charge	$Q_{GS}$				8.2		
Gate-to-Drain Charge	$Q_{GD}$				21.7		1
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -10 \text{ V}, V_{DS} = -15 \text{ V},$ $I_D = -10 \text{ A}$			62.3	105	1
SWITCHING CHARACTERISTICS, Vo	GS = <b>4.5 V</b> (Note 3	3)					
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS} = -4.5 \text{ V, V}$	<sub>DS</sub> = -15 V,		25		ns
Rise Time	t <sub>r</sub>	$I_D = -10 \text{ A}, \text{ F}$	$R_{G} = 6 \Omega$		138		
Turn-Off Delay Time	t <sub>d(off)</sub>				55		
Fall Time	t <sub>f</sub>				98		1
SWITCHING CHARACTERISTICS, Vo	GS = 10 V (Note 3	3)				•	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS} = -10 \text{ V}, \text{ V}_{I}$	<sub>OS</sub> = -15 V,		6		ns
Rise Time	t <sub>r</sub>	$I_D = -10 \text{ A}, F$	$R_{G} = 6 \Omega$		17		1
Turn-Off Delay Time	t <sub>d(off)</sub>				52		1
Fall Time	t <sub>f</sub>				63		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS				-	-	<u></u>
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		-0.8	-1.3	V
		$I_S = -10 \text{ A}$	T <sub>J</sub> = 125°C		-0.65		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_s/dt$			40.7		ns
Charge Time	ta	I <sub>s</sub> = -10 A			18.4		1
Discharge Time	t <sub>b</sub>				22.3		1
Reverse Recovery Charge	Q <sub>RR</sub>				29		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width  $\leq$  300 µs, Duty Cycle  $\leq$  2%.

#### **TYPICAL CHARACTERISTICS**

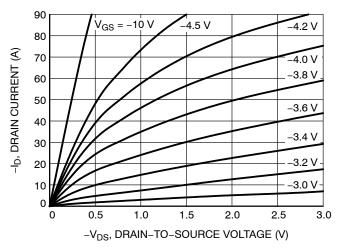


Figure 1. On-Region Characteristics

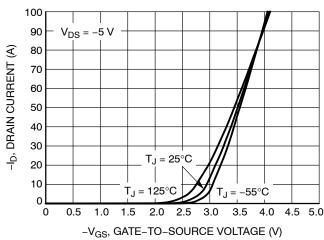


Figure 2. Transfer Characteristics

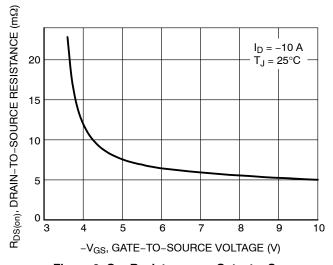


Figure 3. On-Resistance vs. Gate-to-Source Voltage

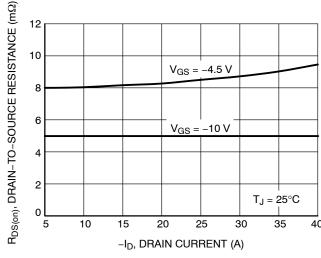


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

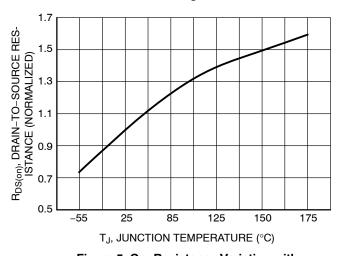


Figure 5. On–Resistance Variation with Temperature

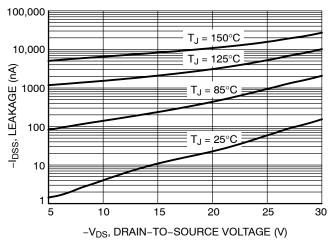


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

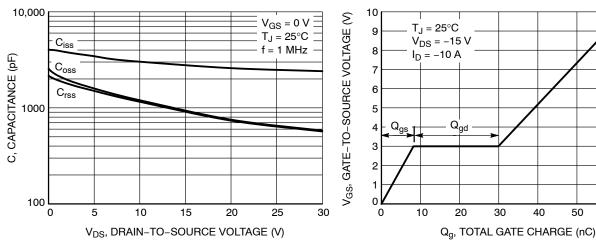


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source vs. Total Charge

60

70

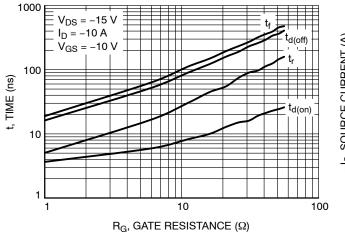


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

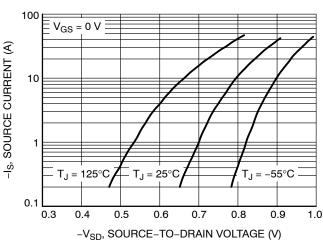


Figure 10. Diode Forward Voltage vs. Current

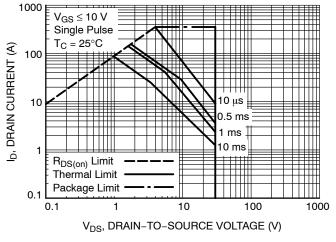


Figure 11. Maximum Rated Forward Biased Safe Operating Area

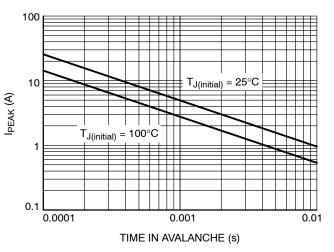


Figure 12. Maximum Drain Current vs. Time in Avalanche

### **TYPICAL CHARACTERISTICS**

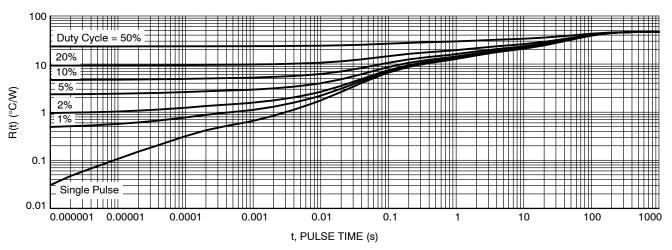


Figure 13. Thermal Response

### **DEVICE ORDERING INFORMATION**

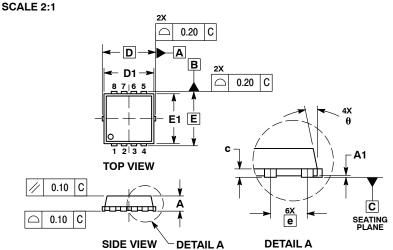
Device	Marking	Package	Shipping <sup>†</sup>
NVTFS015P03P8ZTAG	15P3	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFWS015P03P8ZTAG	15PW	WDFN8 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



#### WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

**DATE 23 APR 2012** 



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
  PROTRUSIONS OR GATE BURRS.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC	;
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		0	.130 BSC	;
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е		0.65 BSC	;	(	0.026 BS	0
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °



#### **GENERIC MARKING DIAGRAM\***

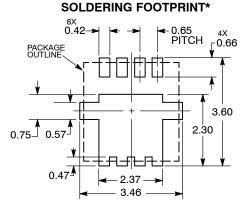


XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.



DIMENSION: MILLIMETERS

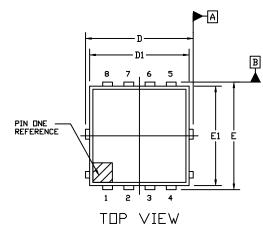
\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON30561E	Electronic versions are uncontrolled except when accessed directly from the Document Repositor, Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	WDFN8 3.3X3.3, 0.65P		PAGE 1 OF 1	

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**DATE 25 AUG 2020** 



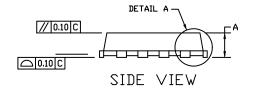


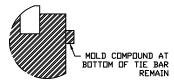
#### NDTES:

- 1. DIMENSIONING AND TOLERANCING PERASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION D1 AND E1 D0 NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

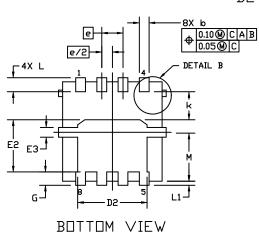
	PLATED AREA
DETAIL	C C SEATING PLANE

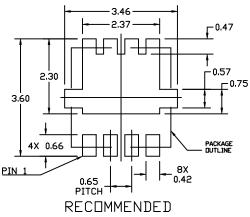
	MILLIMETERS			
DIM	MIN.	NDM.	MAX.	
A	0.70	0.75	0.80	
A1	0.00		0.05	
ø	0.23	0.30	0.40	
n	0.15	0.20	0.25	
D	3.05	3.30	3.55	
D1	2.95	3.05	3.15	
D2	1.98	2.11	2.24	
Ε	3.05	3.30	3.55	
E1	2.95	3.05	3.15	
E2	1.47	1.60	1.73	
E3	0.23	0.30	0.40	
a		0.65 BSC		
G	0.30	0.41	0.51	
K	0.65	0.80	0.95	
٦	0.30	0.43	0.59	
L1	0.06	0.13	0.20	
М	1.40	1.50	1.60	





DETAIL B





MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

# GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

= Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

(Note: Microdot may be in either location)

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DESCRIPTION:	WDFNW8 3.3x3.3, 0.65P (F	WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF)		

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